

INFORMATION DISCLOSURE STATEMENT

FORM PTO 1449 (modified)

ATTY DOCKET NO.
2006_1573ASERIAL NO.
NEW 10/593874U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICEAPPLICANT
Syuichi MATSUI et al.LIST OF REFERENCES CITED BY APPLICANT(S)
(Use several sheets if necessary)FILING DATE
September 22, 2006

GROUP

Date Submitted to PTO: September 22, 2006

U.S. PATENT DOCUMENTS

*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
	AA	6,576,303	6/2003	Tamura et al.	—————	—————	
	AB				—————	—————	
	AC				—————	—————	
	AD				—————	—————	
	AE				—————	—————	

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO
	AF	8-40953	2/1996	Japan	—————	—————	
	AG	43 38 348	5/1994	Germany	—————	—————	
	AH	2004-75667	3/2004	Japan	—————	—————	
	AI				—————	—————	
	AK				—————	—————	

OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)

	AL	Pamphlet of WO 0039063, July 6, 2000.
	AM	Peer Kirsch et al., "Nematic Liquid Crystals with Negative Dielectric Anisotropy: Molecular Design and Synthesis" Synlett, No. 4, ISSN: 0936-5214, pages 389-396, 1999.
	AN	Peer Kirsch et al., "Nematic Liquid Crystals for Active Matrix Displays: Molecular Design and Synthesis", Angew. Chem. Int. Ed., 39, pages 4216-4235, 2000.
	AO	
	AP	

EXAMINER /Shean Wu/

DATE CONSIDERED

01/07/2009

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of form with next communication to applicant.

ALL REFERENCES CONSIDERED EXCEPT WHERE LINED THROUGH. /SW/